

## SEMITOP® 3

### **Boost Chopper**

### **SK 120 GAL 12F4 T**

### Features\*

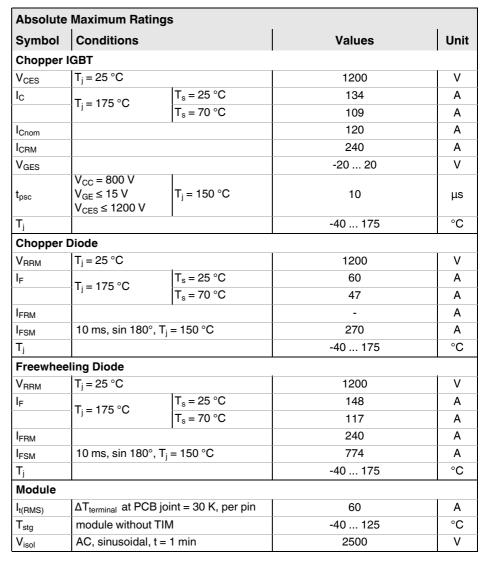
- · One screw mounting module
- · Low inductive design
- · Heat transfer and insulation through
- direct copper bonded aluminum oxide ceramic (DBC)
- 1200V Trench4 IGBT (F4)
- Robust and soft switching freewheeling diode CAL4F
- Integrated NTC temperature sensor
- UL recognized, file no. E 63 532

### **Typical Applications**

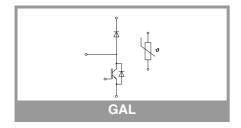
- Solar
- UPS
- · Energy Storage Systems

### **Remarks**

· Chopper Diode: antiparallel diode



Characteristics									
Symbol	Conditions	min.	typ.	max.	Unit				
Chopper	IGBT		•			•			
V <sub>CE(sat)</sub>	I <sub>C</sub> = 120 A	T <sub>j</sub> = 25 °C		2.05	2.40	V			
	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 150 °C		2.59	2.85	V			
V <sub>CE0</sub>	chiplevel	T <sub>j</sub> = 25 °C		0.80	0.90	V			
		T <sub>j</sub> = 150 °C		0.70	0.80	V			
r <sub>CE</sub>	V <sub>GE</sub> = 15 V chiplevel	T <sub>j</sub> = 25 °C		10	13	mΩ			
		T <sub>j</sub> = 150 °C		16	17	mΩ			
$V_{GE(th)}$	$V_{GE} = V_{CE}$ , $I_C = 4.5$ mA		5.2	5.8	6.4	V			
I <sub>CES</sub>	$V_{GE} = 0 \text{ V}, V_{CE} = 1200 \text{ V}, T_j = 25 ^{\circ}\text{C}$			-	1.6	mA			
C <sub>ies</sub>	V <sub>CE</sub> = 25 V V <sub>GE</sub> = 0 V	f = 1 MHz		6.90		nF			
Coes		f = 1 MHz		0.56		nF			
C <sub>res</sub>		f = 1 MHz		0.41		nF			
$Q_{G}$	V <sub>GE</sub> = - 15 V+ 15 V			840		nC			
R <sub>Gint</sub>	T <sub>j</sub> = 25 °C		1.6		Ω				





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**Typical Applications** 

• Solar

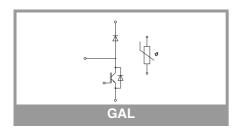
• UPS

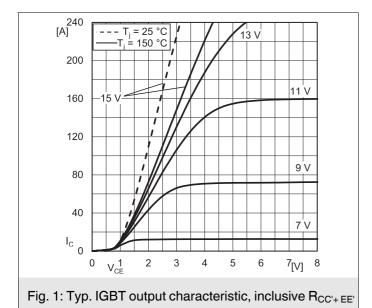
• Energy Storage Systems

**Remarks** 

• Chopper Diode: antiparallel diode

Characteristics										
Symbol	Conditions		min.	typ.	max.	Unit				
Chopper I				• •						
t <sub>d(on)</sub>	V <sub>CC</sub> = 600 V	T <sub>i</sub> = 150 °C		98		ns				
t <sub>r</sub>	I <sub>C</sub> = 120 A	T <sub>i</sub> = 150 °C		31		ns				
E <sub>on</sub>	$R_{G \text{ on}} = 1.5 \Omega$	T <sub>i</sub> = 150 °C		13.9		mJ				
t <sub>d(off)</sub>	$R_{G \text{ off}} = 1.5 \Omega$ $di/dt_{on} = 3200 \text{ A/}\mu\text{s}$	,		306		ns				
t <sub>f</sub>	$di/dt_{off} = 1900 \text{ A/}\mu\text{s}$	T <sub>i</sub> = 150 °C		46		ns				
E <sub>off</sub>	$V_{GE} = +15/-15 \text{ V}$ $dv/dt = 1990 \text{ V/}\mu\text{s}$	T <sub>j</sub> = 150 °C		9		mJ				
R <sub>th(j-s)</sub>	per IGBT, $\lambda_{paste}$ =0.8			0.35		K/W				
Chopper Diode										
$V_F = V_{EC}$	I <sub>F</sub> = 13 A	T <sub>i</sub> = 25 °C		0.97	1.20	V				
	ahinlayal	T <sub>j</sub> = 150 °C		0.84	1.07	V				
V <sub>F0</sub>	chiplevel chiplevel	T <sub>i</sub> = 25 °C		0.89	1.09	V				
		T <sub>i</sub> = 150 °C		0.73	0.92	V				
r_		$T_i = 25 ^{\circ}\text{C}$		6.2	8.5	mΩ				
r <sub>F</sub>	chiplevel	T <sub>i</sub> = 150 °C		8.8	12	mΩ				
I <sub>RRM</sub>	I <sub>F</sub> = 13 A	11 100 0		-	12	Α				
Q <sub>rr</sub>						μC				
Err						mJ				
	per Diode ) -0	9 \M/(mK)		1.5		K/W				
R <sub>th(j-s)</sub>	per Diode, λ <sub>paste</sub> =0.	o w/(iiik)		1.5		IV/VV				
V <sub>F</sub> = V <sub>EC</sub>	ling Diode	T <sub>i</sub> = 25 °C		2.17	2.49	V				
VF = VEC	_	$T_i = 150 ^{\circ}\text{C}$				V				
	chiplevel	*		2.11	2.42					
V <sub>F0</sub>	chiplevel	T <sub>j</sub> = 25 °C		1.30	1.50	V				
		T <sub>j</sub> = 150 °C		0.90	1.10	V				
r <sub>F</sub>	chiplevel	T <sub>j</sub> = 25 °C		5.8	6.6	mΩ				
		T <sub>j</sub> = 150 °C		8.1	8.8	mΩ				
I <sub>RRM</sub>	$I_F = 120 \text{ A}$ $di/dt_{off} = 3200 \text{ A/µs}$ $V_{GE} = -15 \text{ V}$	T <sub>j</sub> = 150 °C		112		Α				
Q <sub>rr</sub>				21		μC				
E <sub>rr</sub>	V <sub>R</sub> = 600 V	T <sub>j</sub> = 150 °C		7.7		mJ				
R <sub>th(j-s)</sub>	per Diode, $\lambda_{paste}=0$ .	8 W/(mK)		0.45		K/W				
Module						_				
L <sub>CE</sub>				-		nH				
R <sub>CC'+EE'</sub>		T <sub>s</sub> = 25 °C		-		mΩ				
		T <sub>s</sub> = 150 °C		-		mΩ				
Ms	to heatsink	,	2.25		2.5	Nm				
Mt				-		Nm				
				-		Nm g				
W	29									
	ure Sensor	0)		100 ===:						
R <sub>100</sub>	T <sub>c</sub> =100°C (R <sub>25</sub> =5 kg		493 ± 5%		Ω					
B <sub>100/125</sub>	$R_{(T)}=R_{100}exp[B_{100/1}]$	3550 ±2%			K					





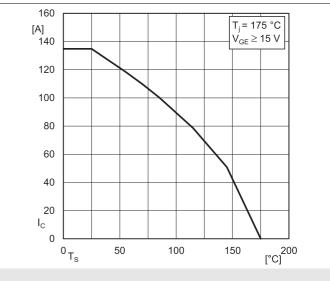


Fig. 2: IGBT rated current vs. temperature I<sub>c</sub>=f(T<sub>s</sub>)

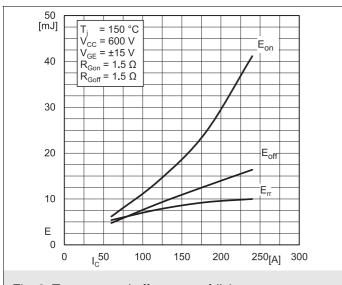


Fig. 3: Typ. turn-on /-off energy =  $f(I_C)$ 

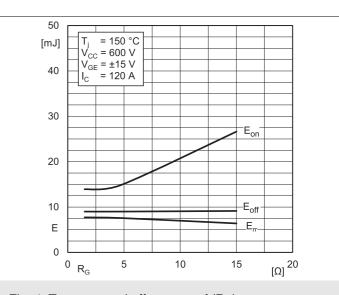


Fig. 4: Typ. turn-on /-off energy =  $f(R_G)$ 

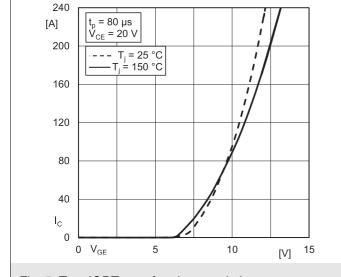


Fig. 5: Typ. IGBT transfer characteristic

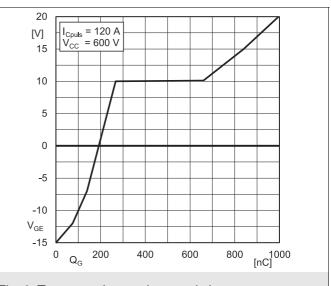
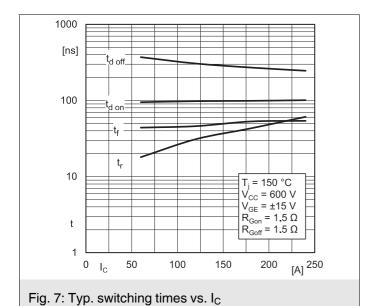


Fig. 6: Typ. gate charge characteristic



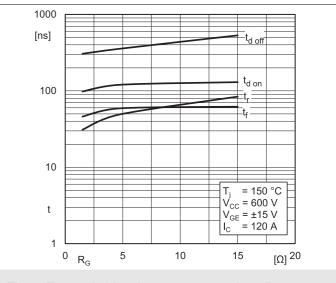


Fig. 8: Typ. switching times vs. gate resistor R<sub>G</sub>

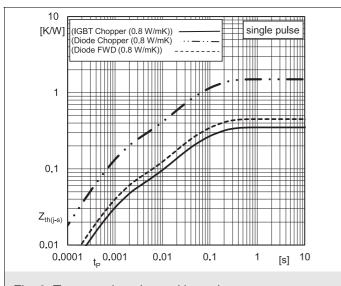


Fig. 9: Typ. transient thermal impedance

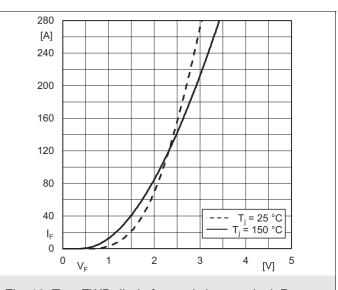


Fig. 10: Typ. FWD diode forward charact., incl.  $R_{\text{CC'+EE'}}$ 

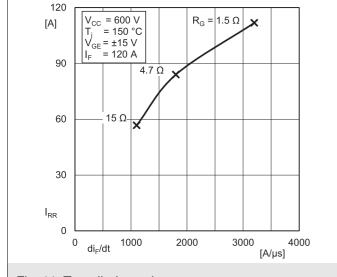


Fig. 11: Typ. diode peak reverse recovery current

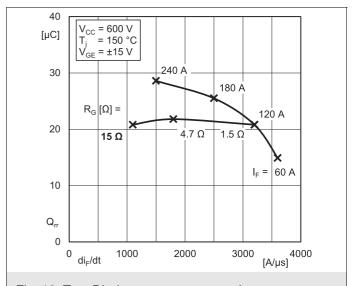
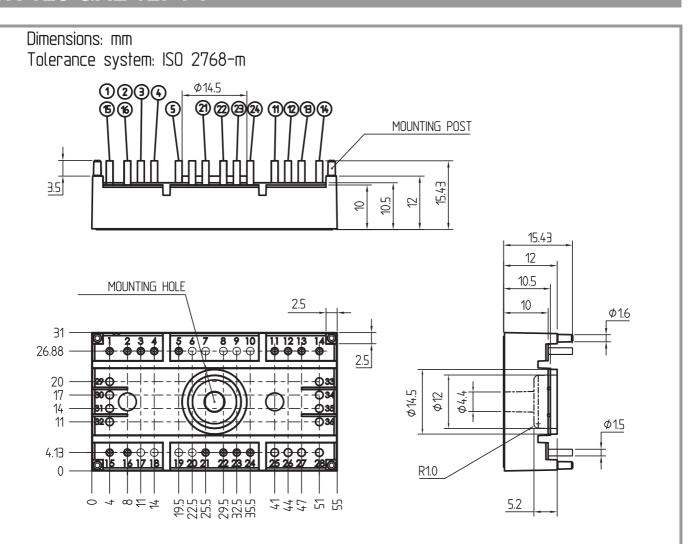


Fig. 12: Typ. Diode reverse recovery charge



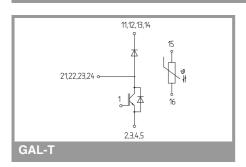
-Hole specification for contacts: refer Mounting Instruction SEMITOP® Classic

suggested hole diameter for the mounting post in the circuit board:

- 2.0 mm

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### SEMITOP®3



This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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